Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/809,548	TANAKA ET AL.	
Examiner	Art Unit	
Yonel Regulieu	3661	

SEARCHED				
Class	Subclass	Date	Examiner	
701	36	12/12/2005	ΥB	
	41			
348	148	12/12/2005	YB	
180	167	12/12/2005	YB	
	199		·	
280	761	12/12/2005	YB	
340	932.2			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

(INCLUDING	ARCH NOTES SEARCH STRATE	GY)
	DATE	EXMR
WEST	12/12/20	005 YB
		